

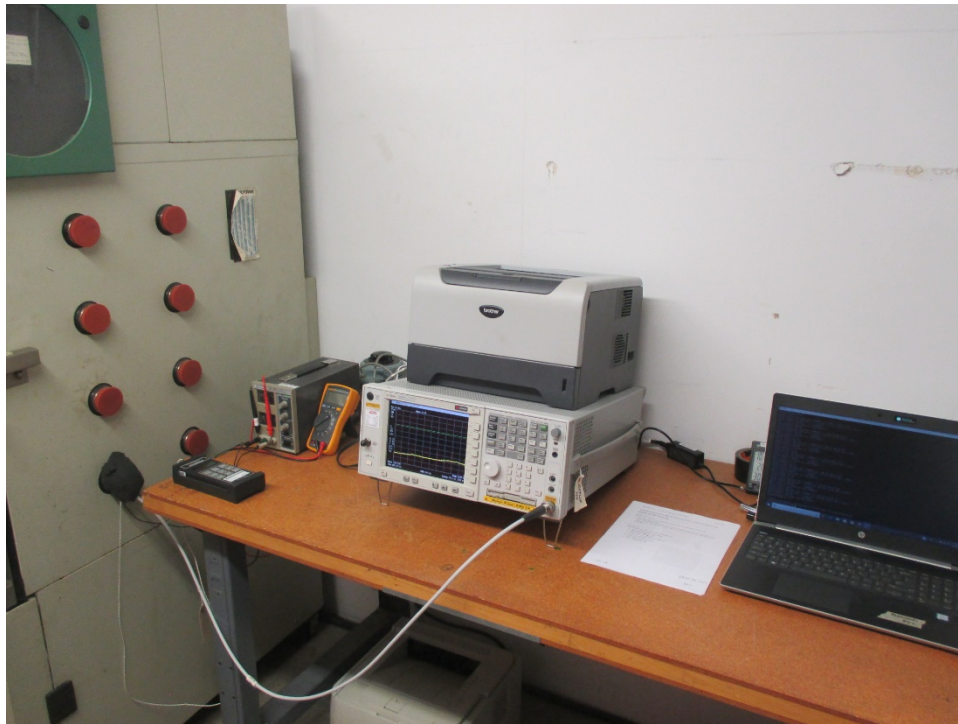
Immedia Semiconductor, LLC
Test Photographs
FCC ID: 2AF77-H2211672



Retlif Testing Laboratories

Report No. R-6689H-1

Test Photographs Channel Separation



Test Setup



Retlif Testing Laboratories

Report No. R-6689H-1

Test Photographs 20 dB Bandwidth



Test Setup



Retlif Testing Laboratories

Report No. R-6689H-1

Test Photographs

Number of Channels and Occupancy Time



Test Setup



Retlif Testing Laboratories

Report No. R-6689H-1

Test Photographs

Number of Hopping Frequencies



Test Setup



Retlif Testing Laboratories

Report No. R-6689H-1

Test Photographs

Peak Conducted Output Power



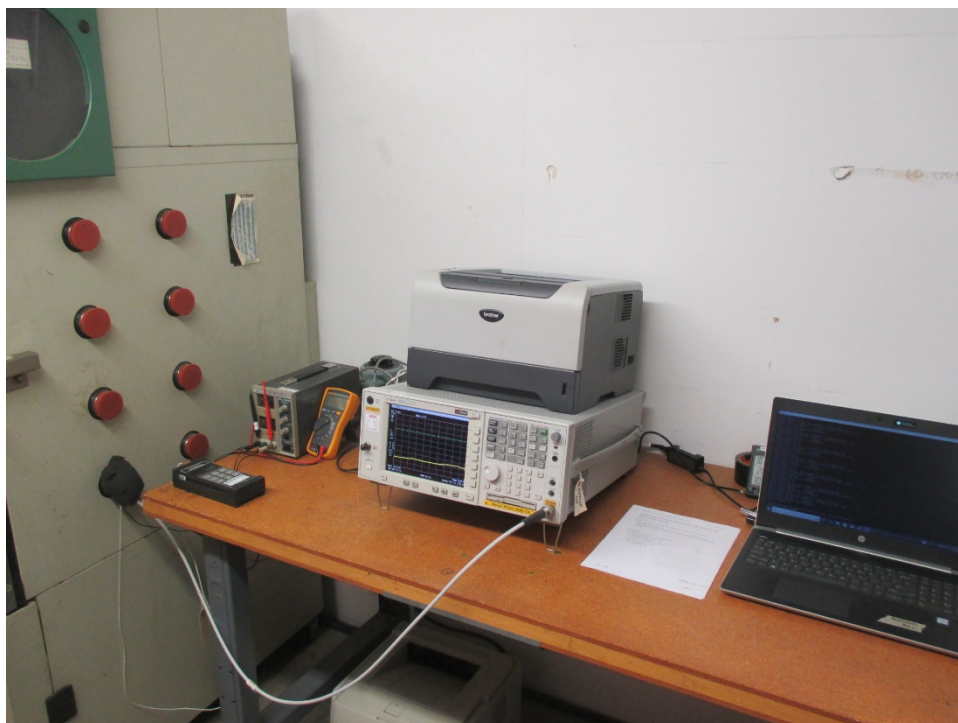
Test Setup



Retlif Testing Laboratories

Report No. R-6689H-1

Test Photographs
Conducted Spurious Emissions, 30 MHz to 10 GHz



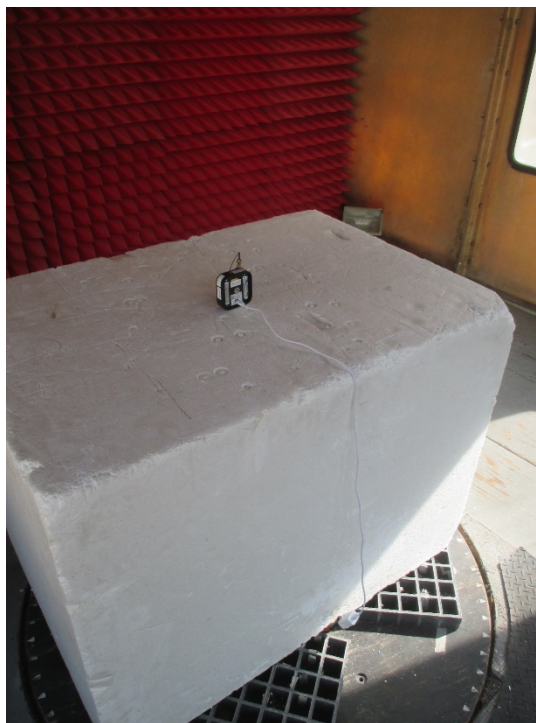
Test Setup



Retlif Testing Laboratories

Report No. R-6689H-1

Test Photographs
Field Strength of Spurious Emissions



EUT Configuration



Retlif Testing Laboratories

Report No. R-6689H-1

Test Photographs
Field Strength of Spurious Emissions



Horizontal Antenna Polarization, 30 to 200 MHz



Vertical Antenna Polarization, 30 to 200 MHz



Retlif Testing Laboratories

Report No. R-6689H-1

Test Photographs
Field Strength of Spurious Emissions



Horizontal Antenna Polarization, 200 MHz to 1 GHz



Vertical Antenna Polarization, 200 MHz to 1 GHz



Retlif Testing Laboratories

Report No. R-6689H-1

Test Photographs
Field Strength of Spurious Emissions



Horizontal Antenna Polarization, 1 GHz to 10 GHz



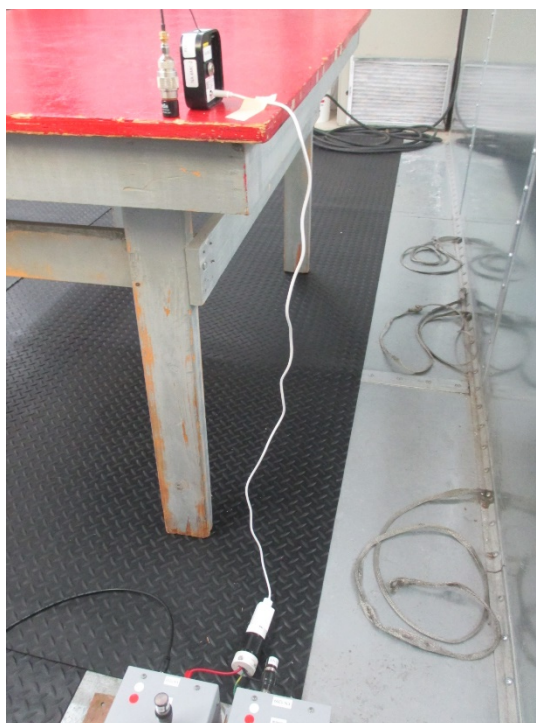
Vertical Antenna Polarization, 1 GHz to 10 GHz



Retlif Testing Laboratories

Report No. R-6689H-1

Test Photographs Conducted Emissions



EUT Configuration



Test Setup



Retlif Testing Laboratories

Report No. R-6689H-1